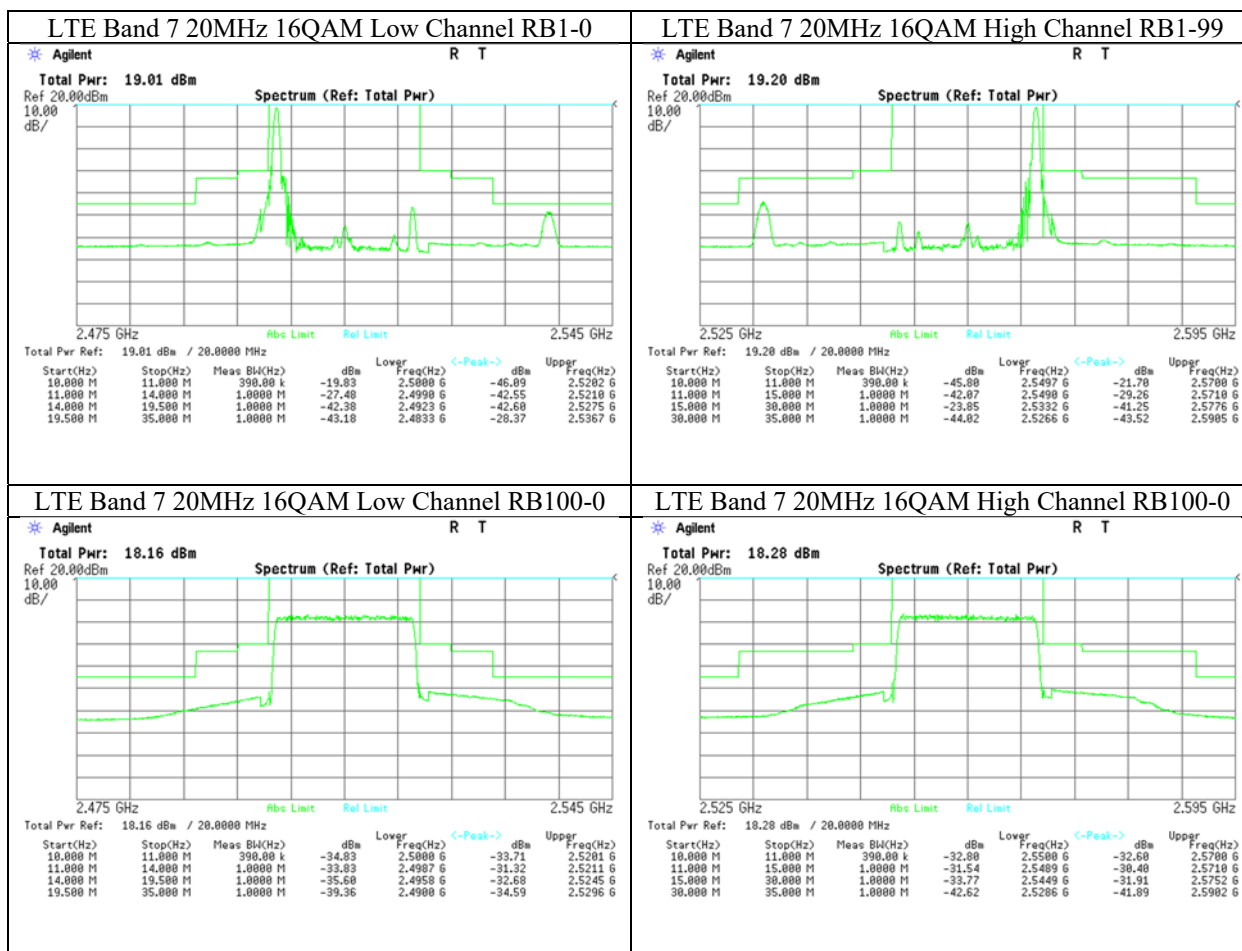


Band Edge (Conducted)

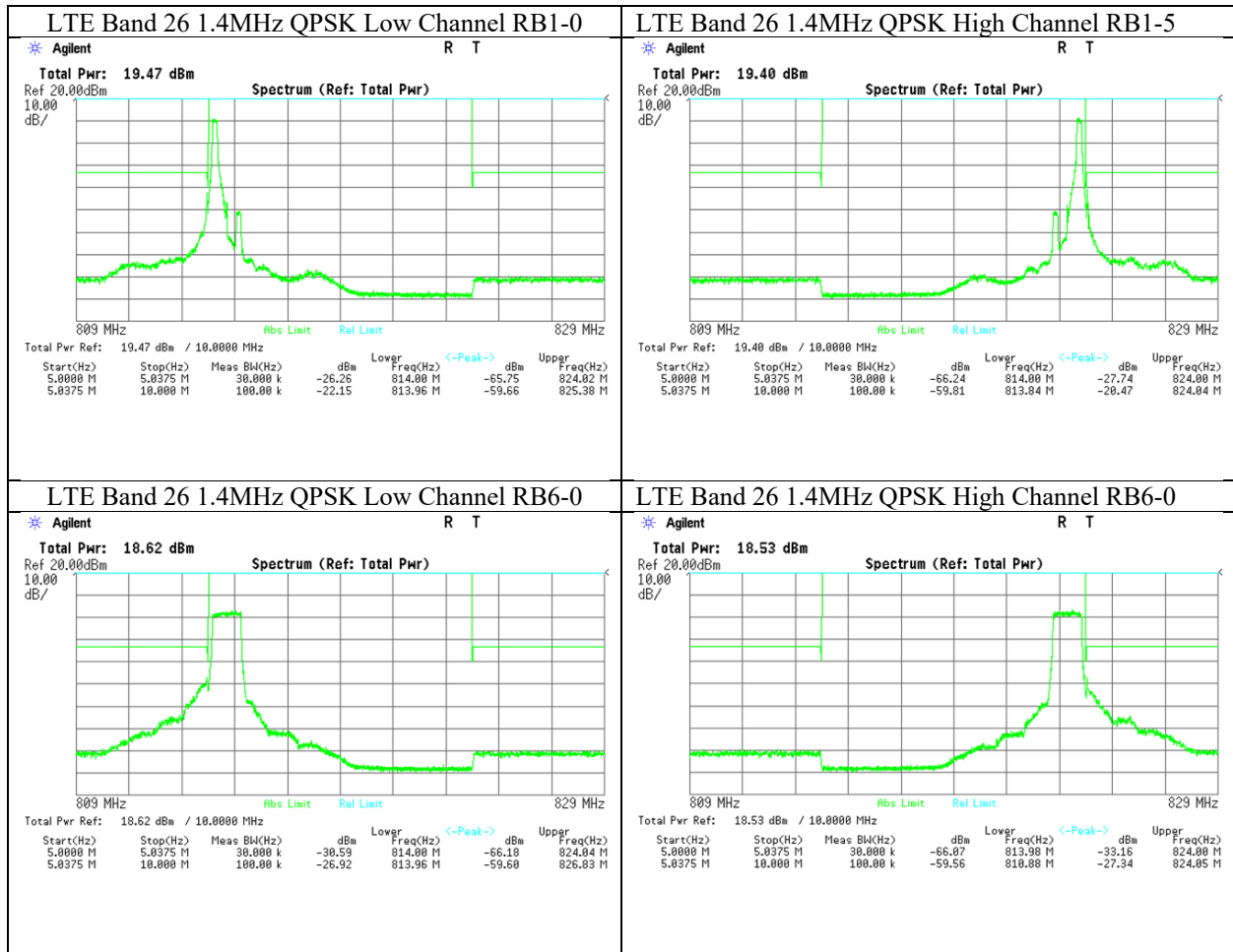
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 19, 2020
Temperature / Humidity 22 deg. C / 46 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Band Edge (Conducted)

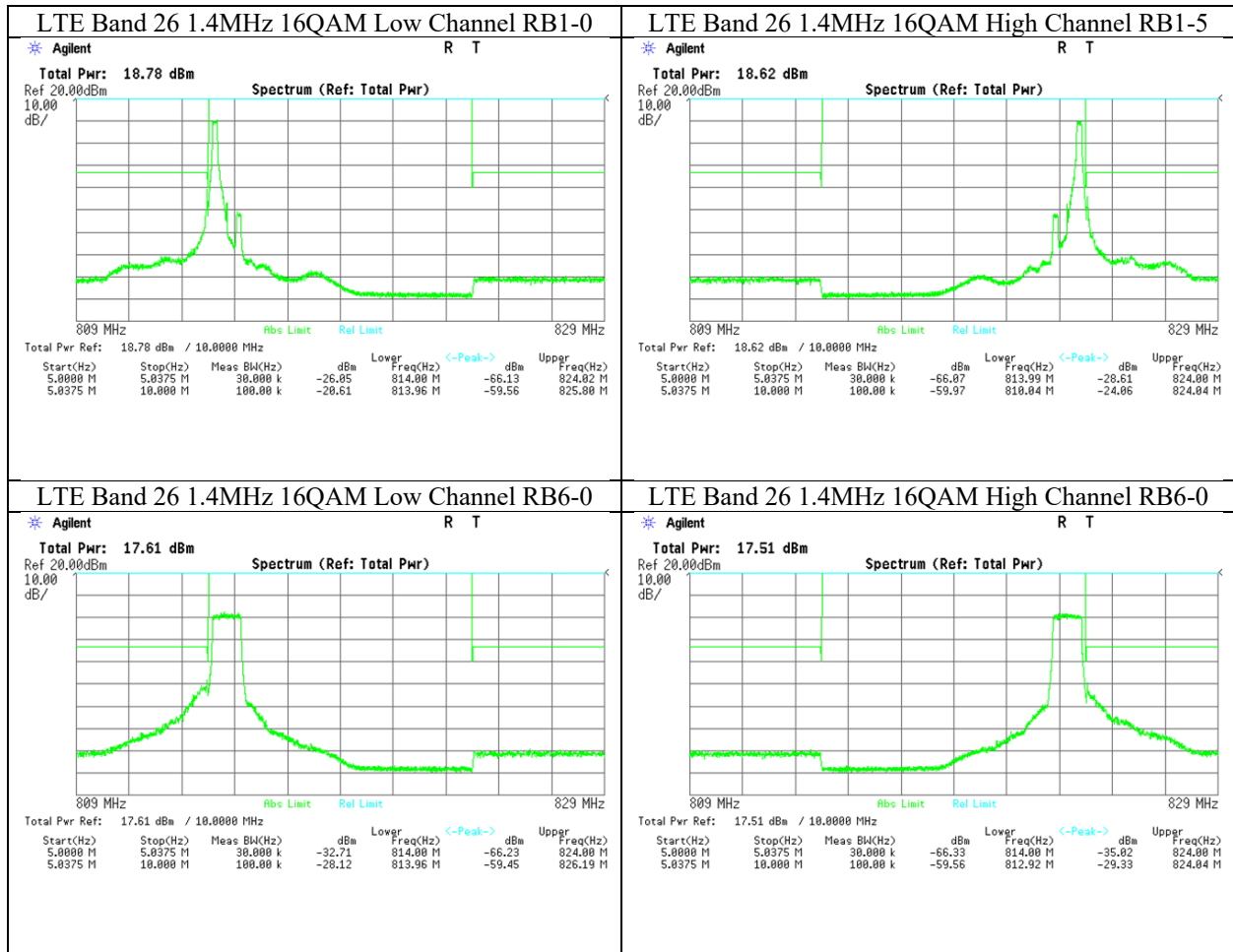
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

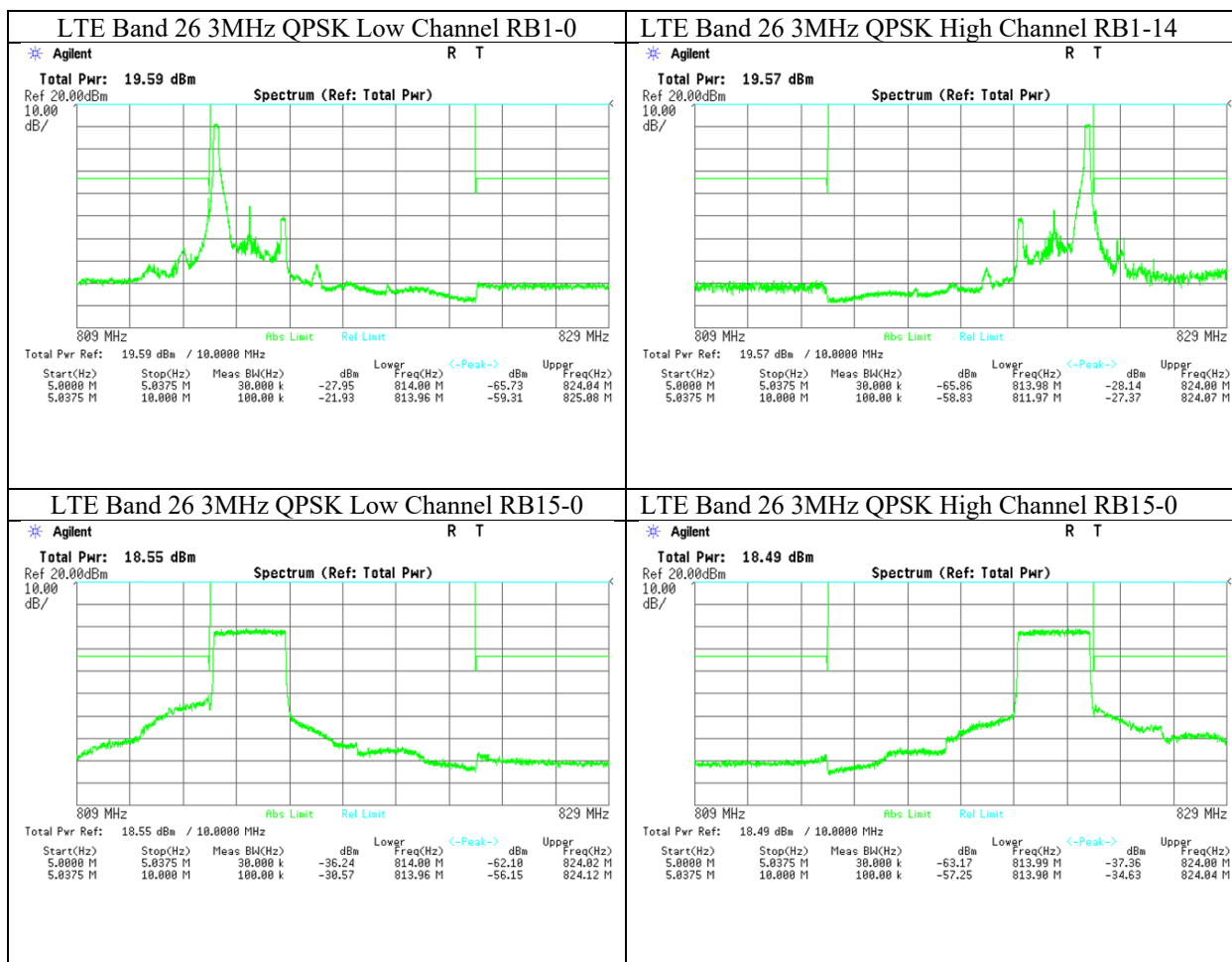
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

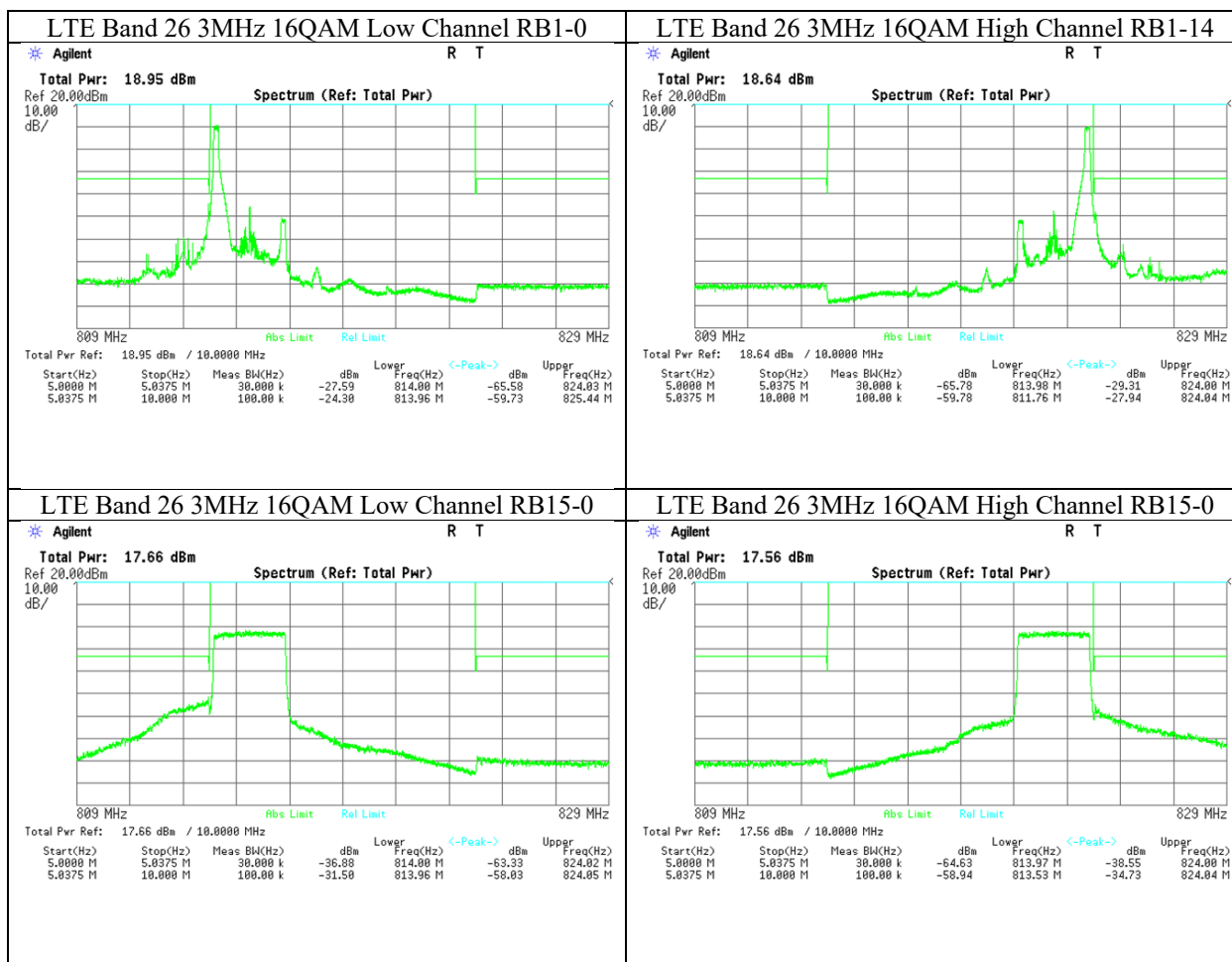
Mode LTE



Band Edge (Conducted)

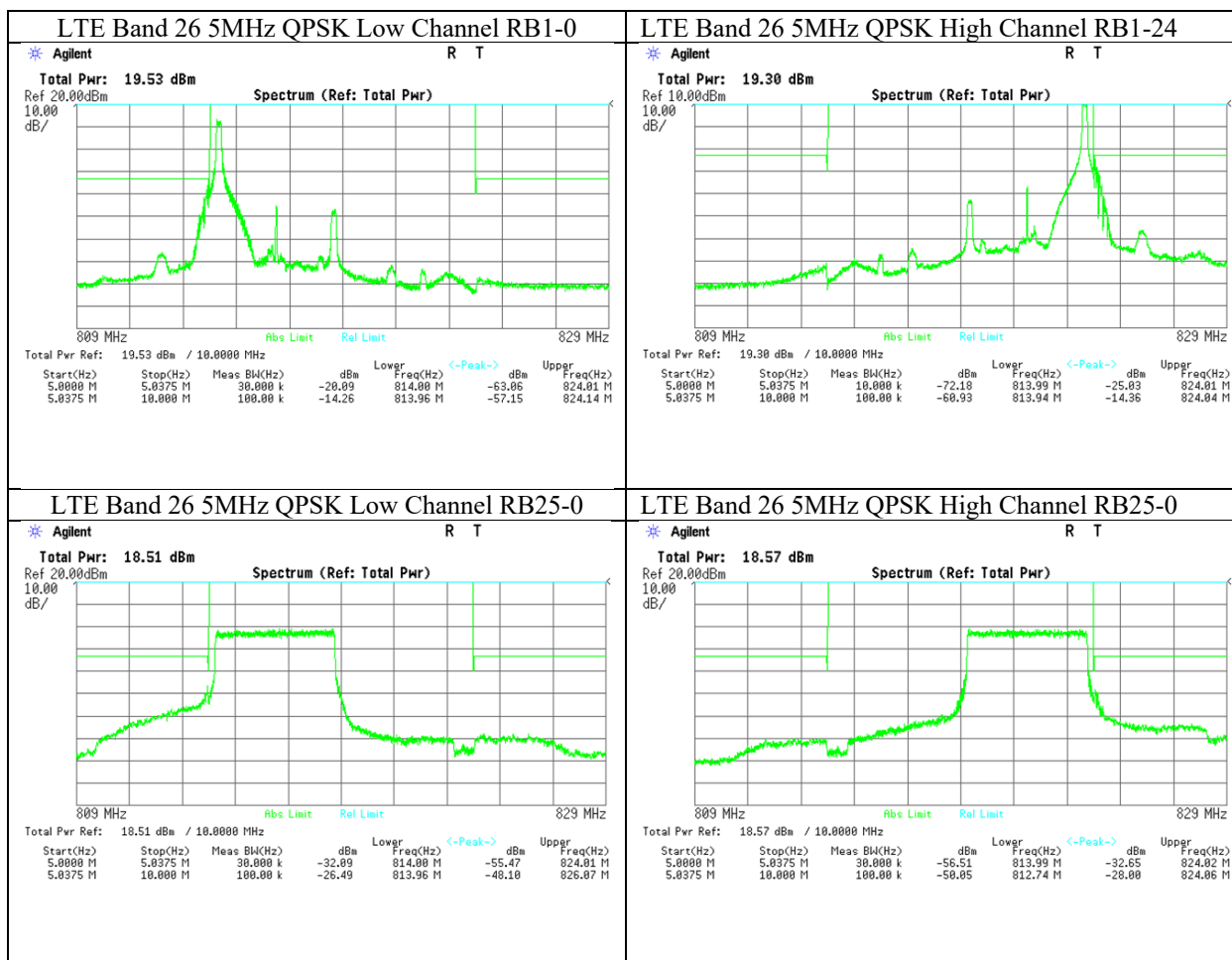
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Band Edge (Conducted)

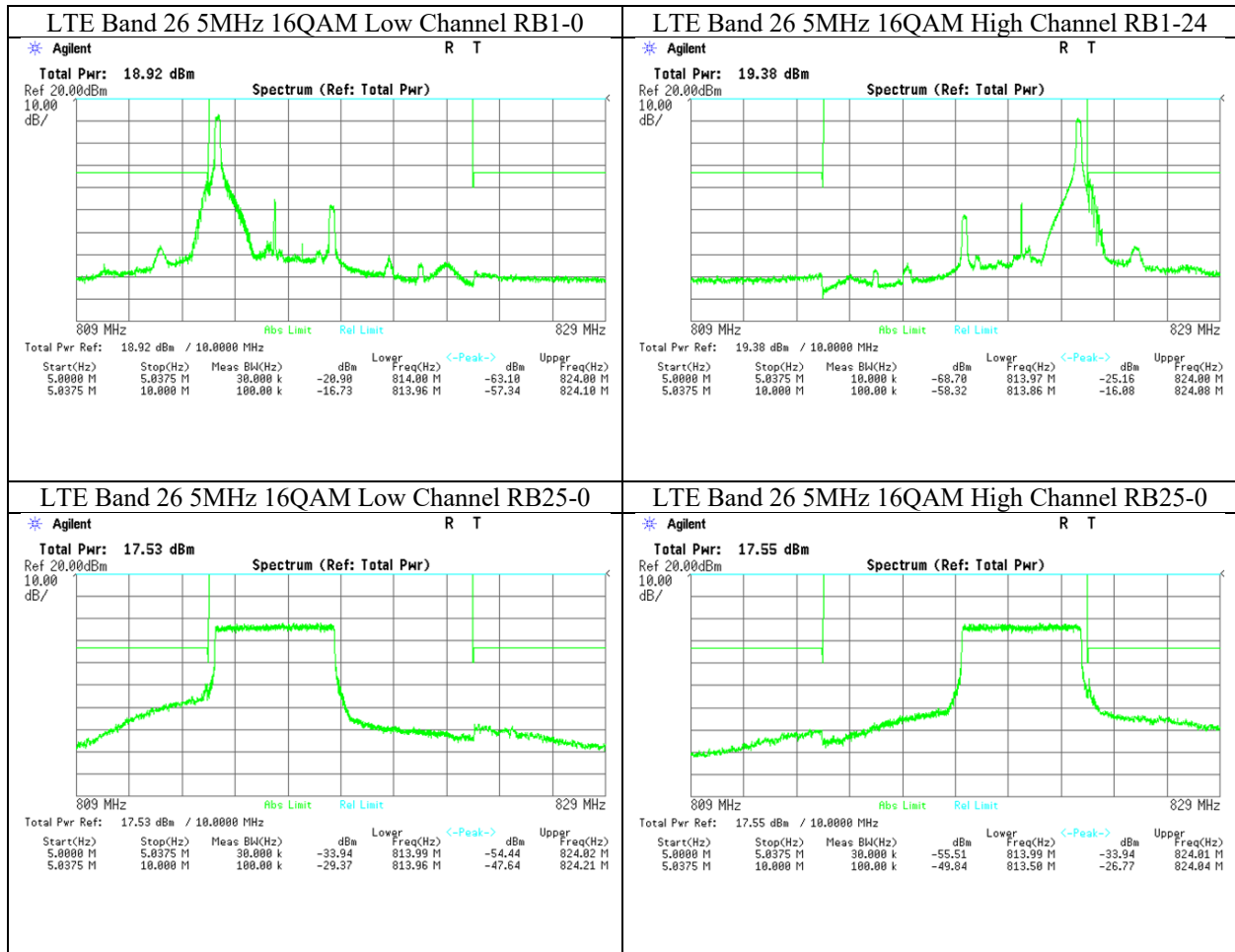
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

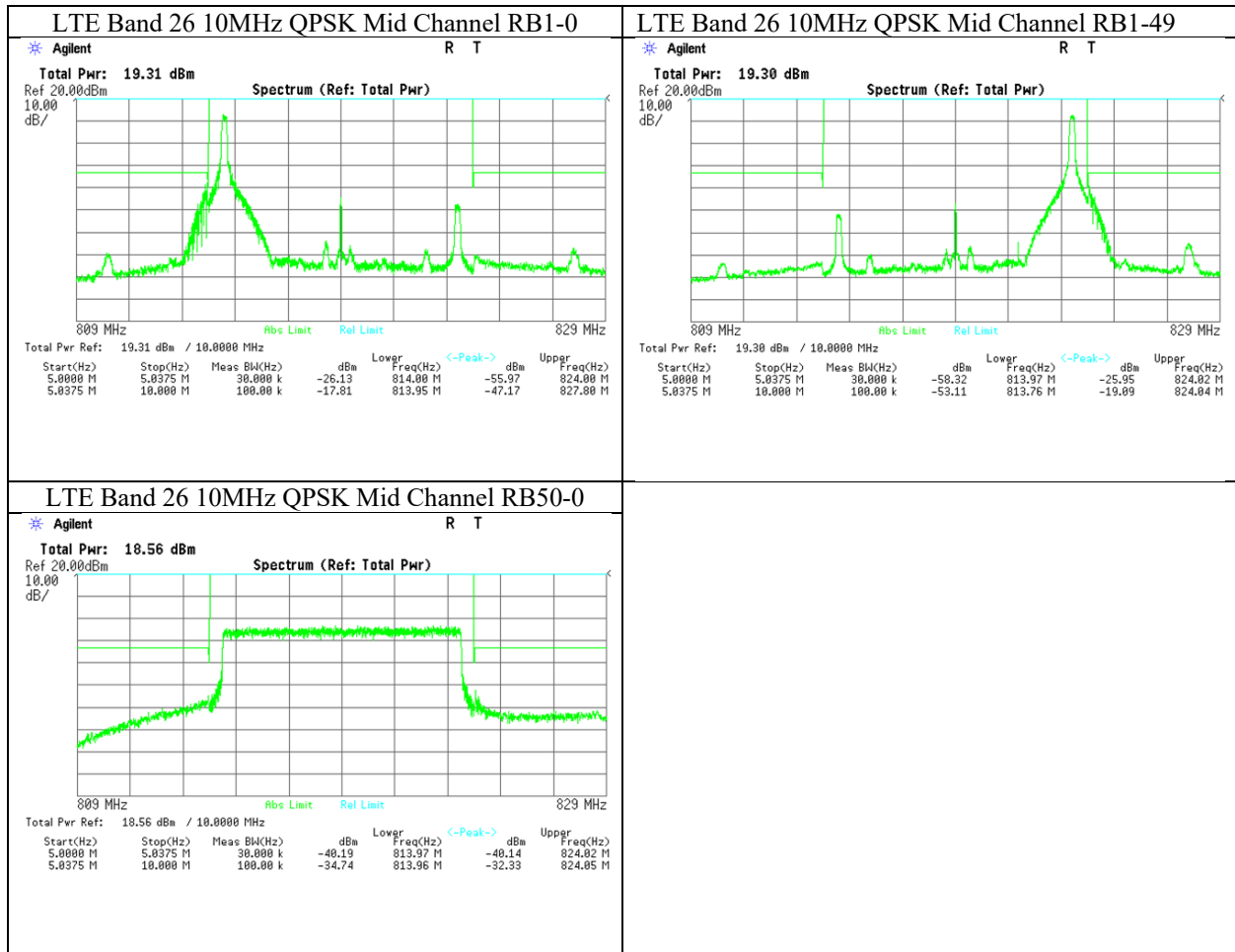
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

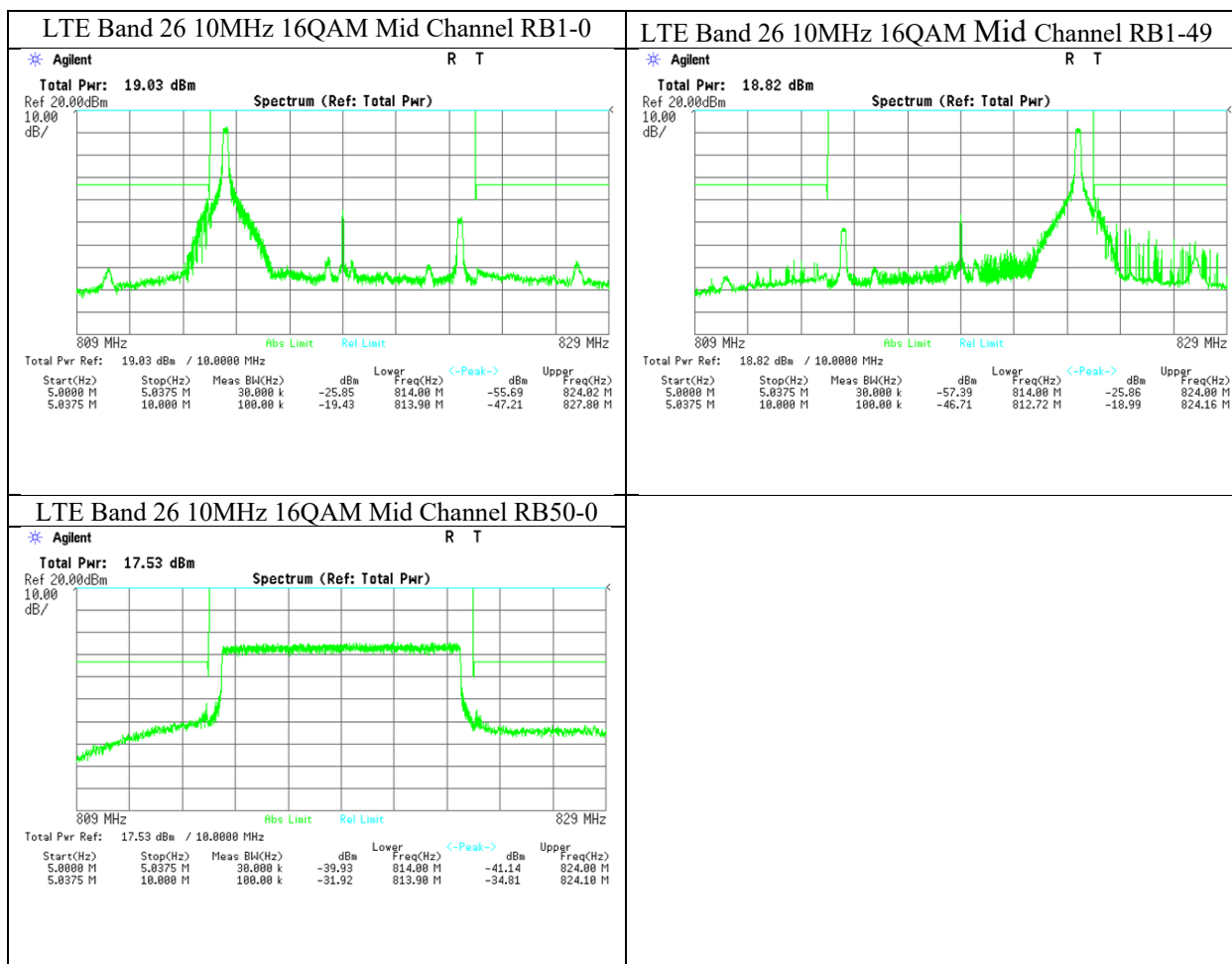
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM



Spurious Emission (Conducted)

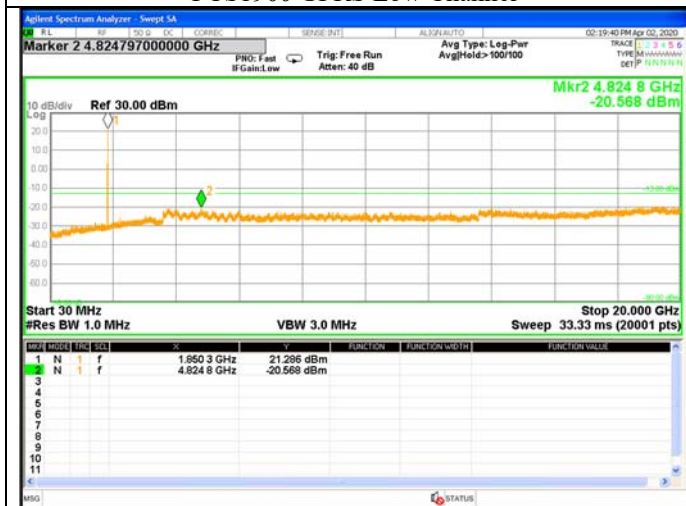
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM



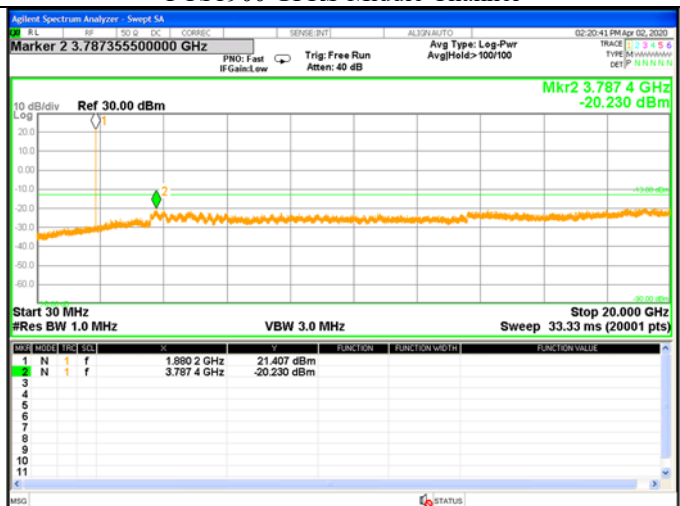
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM

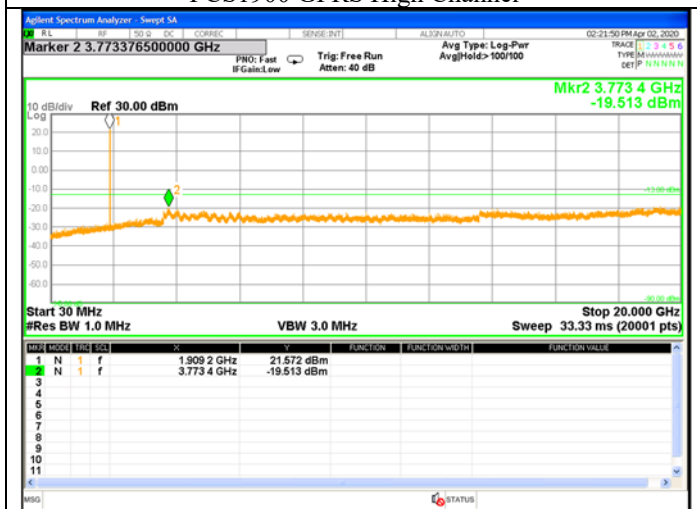
PCS1900 GPRS Low Channel



PCS1900 GPRS Middle Channel



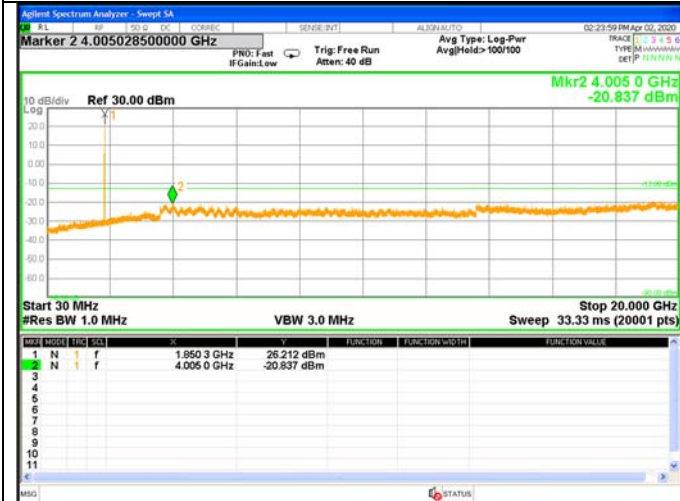
PCS1900 GPRS High Channel



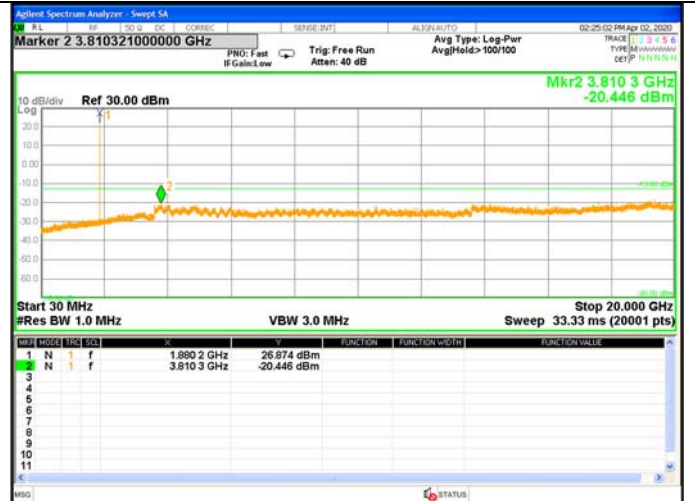
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM

PCS1900 EGPRS Low Channel



PCS1900 EGPRS Middle Channel



PCS1900 EGPRS High Channel



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 16, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



UL Japan, Inc.

Ise EMC Lab.

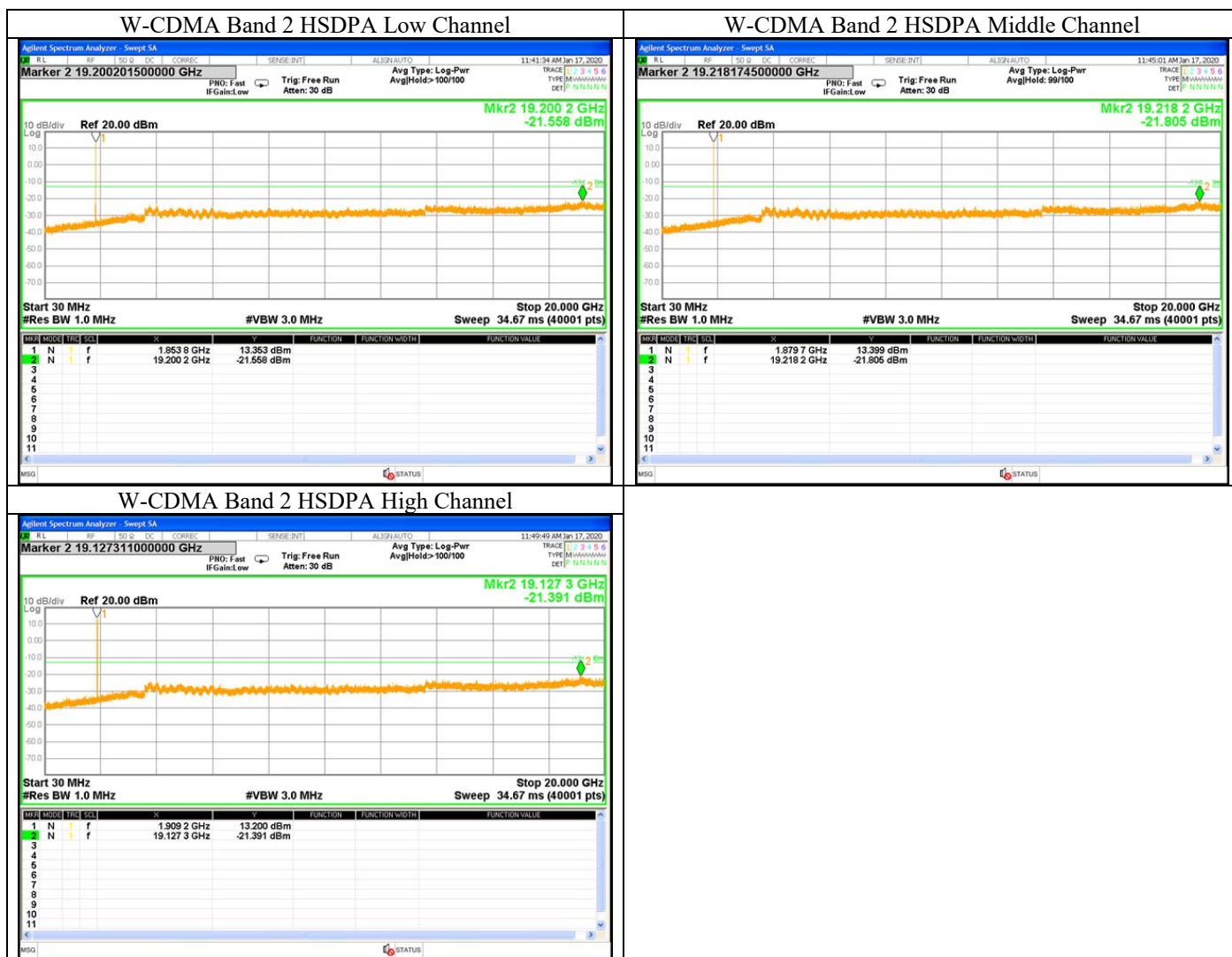
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 17, 2020
Temperature / Humidity 22 deg. C / 43 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



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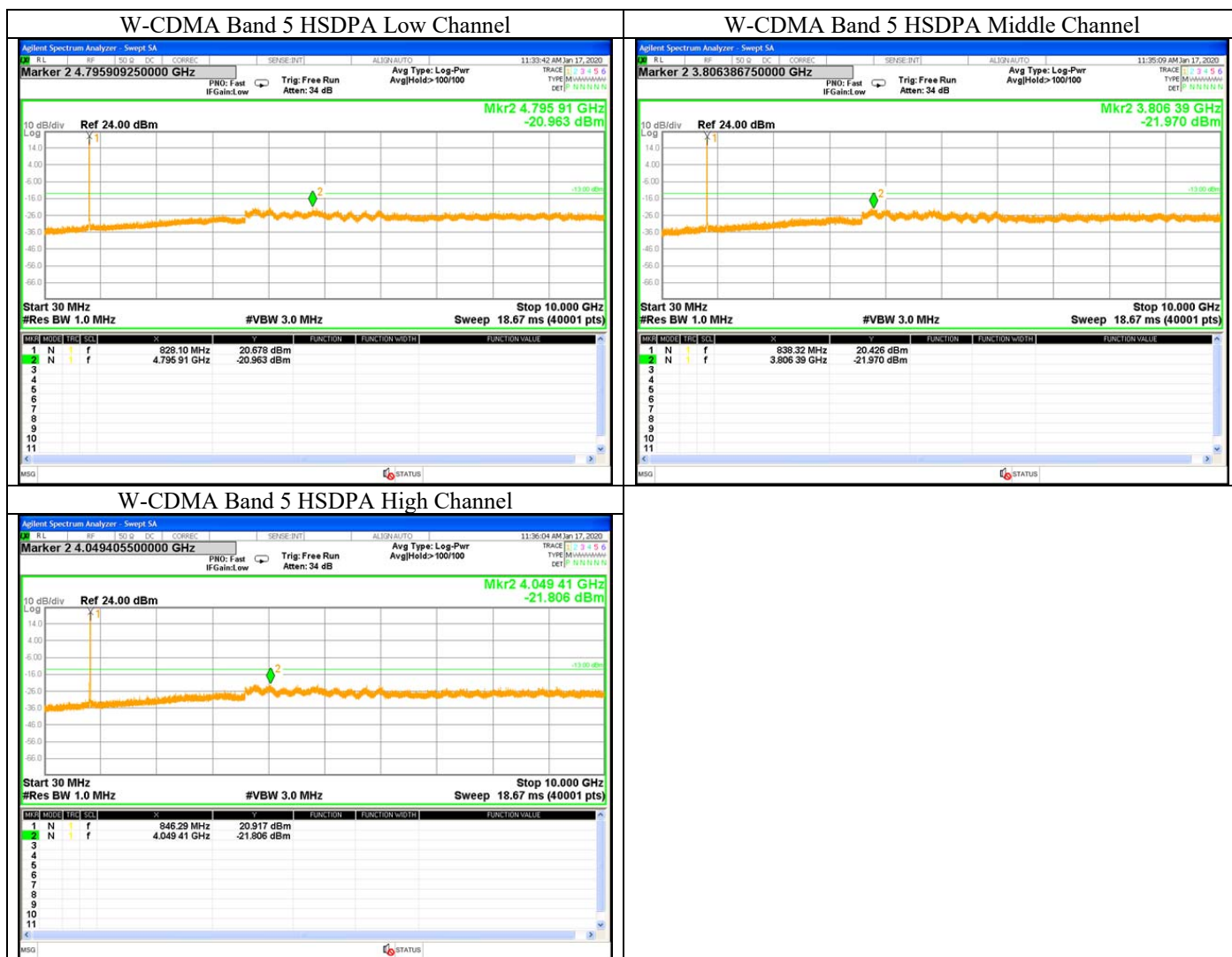
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 16, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 17, 2020
Temperature / Humidity 22 deg. C / 43 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



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Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Spurious Emission (Conducted)

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Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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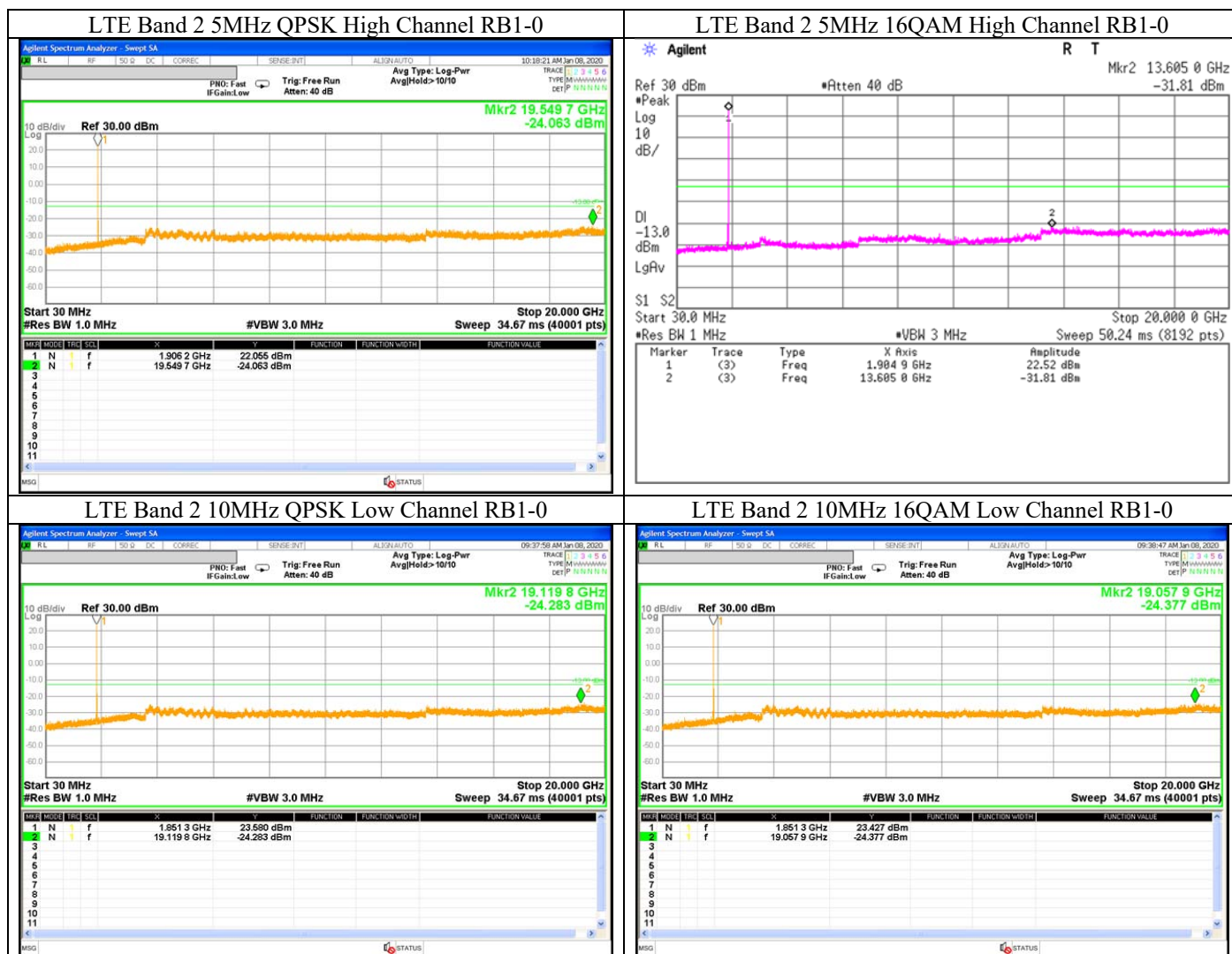
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE

No.6
March 6, 2020
22 deg. C / 44 % RH
Yutaka Yoshida



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Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Ise EMC Lab.

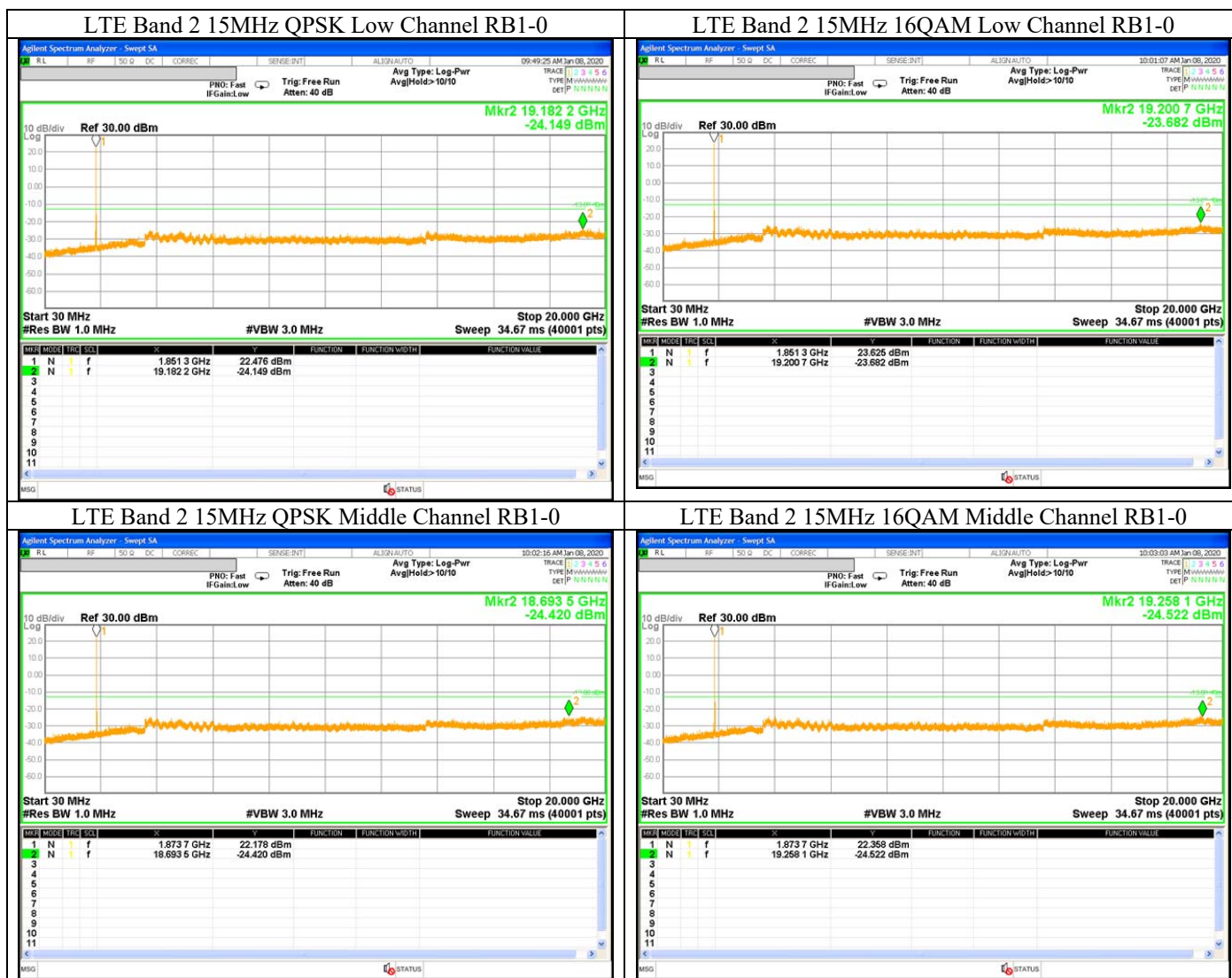
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



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Ise EMC Lab.

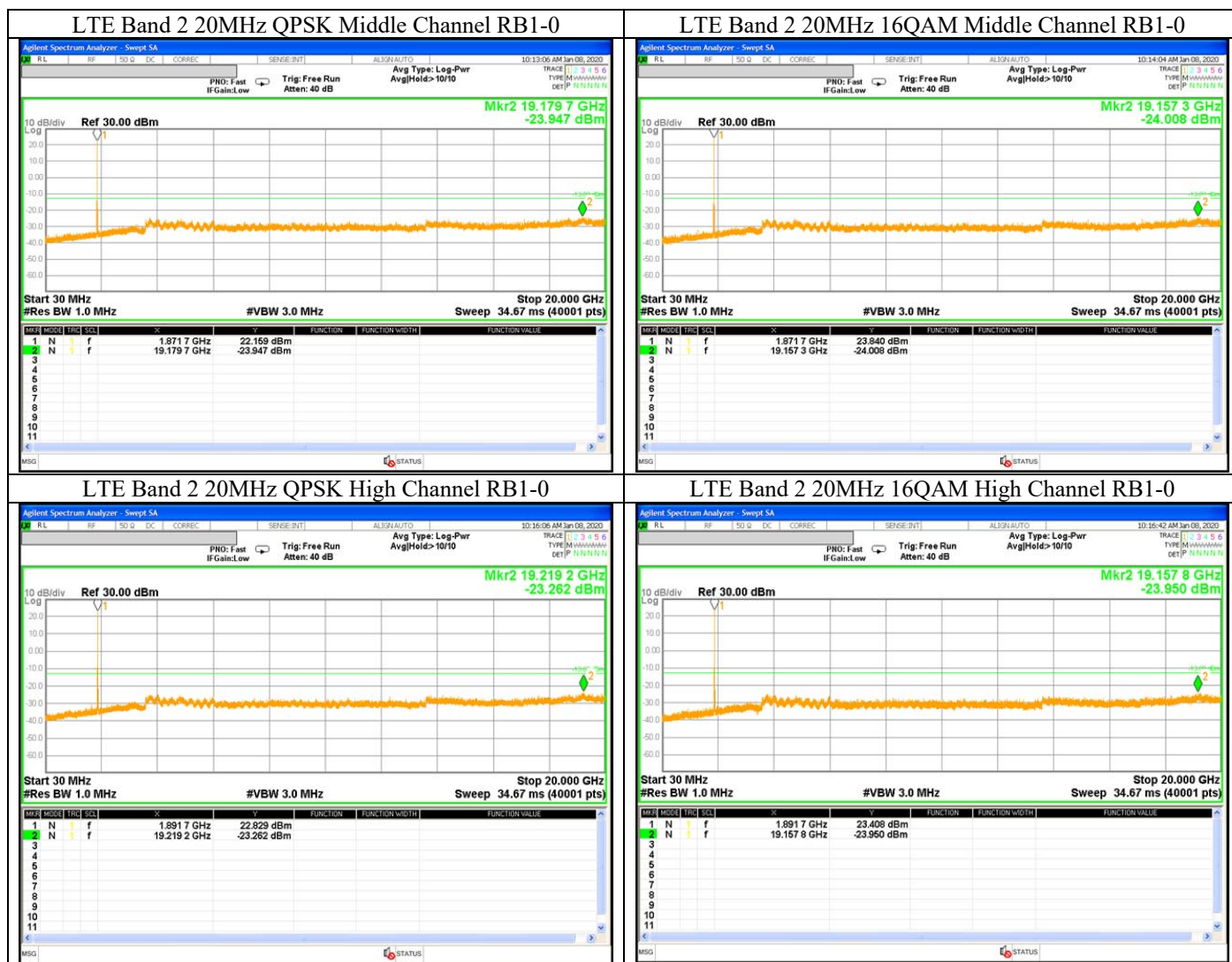
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Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

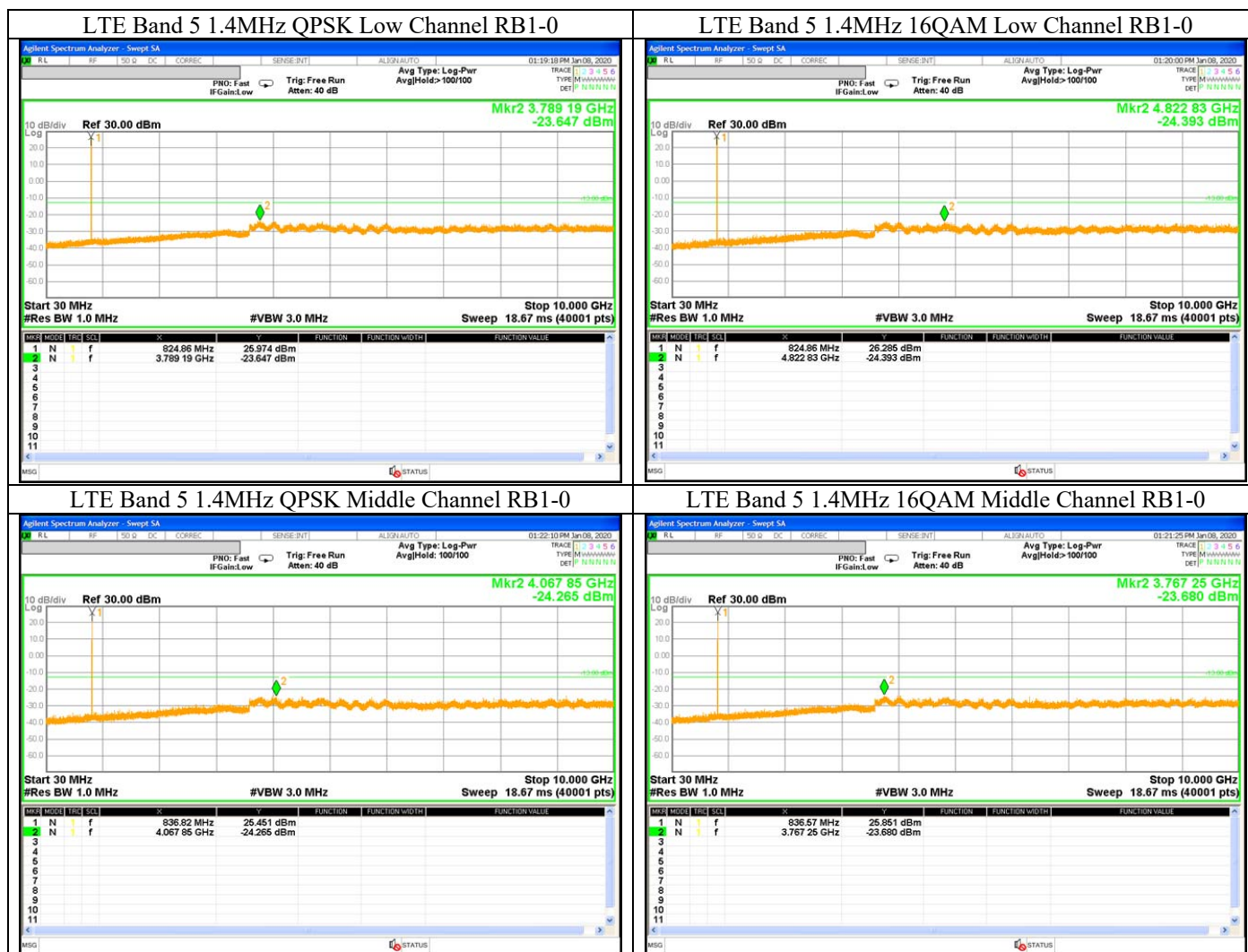
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Shielded Room No.6
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Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

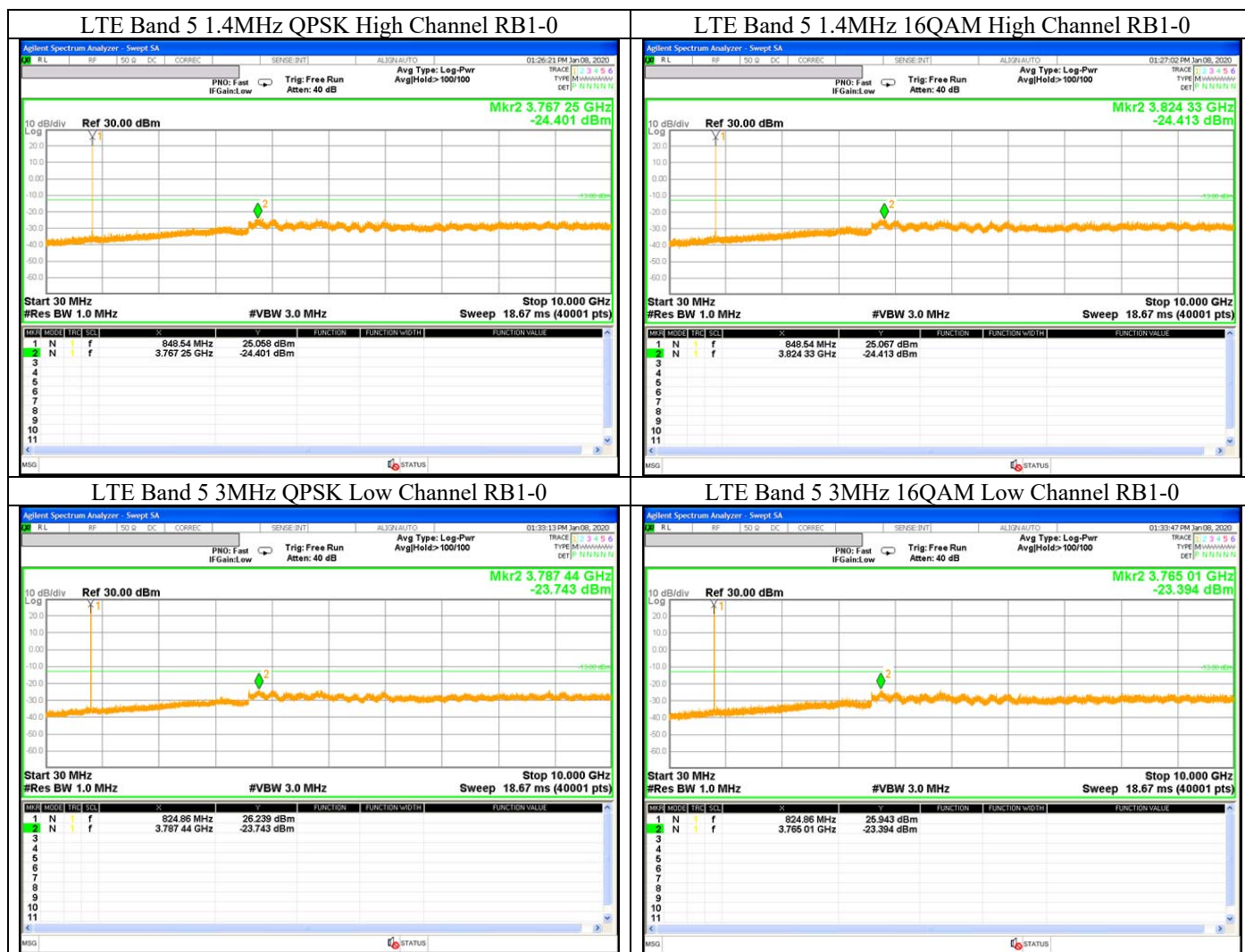
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